


<b>Search Notes</b> 	<b>Application/Control No.</b> 10553624	<b>Applicant(s)/Patent Under Reexamination</b> TAKAHATA ET AL.
	<b>Examiner</b> CHRISTIAN A HANNON	<b>Art Unit</b> 2618

SEARCHED			
Class	Subclass	Date	Examiner
455	569.1	10/10/2008	CH
181	171,172,157	10/10/2008	CH
379	433.02	10/10/2008	CH
381	388,386,333	10/10/2008	CH

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted E. Urban; see printout	10/10/2008	CH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/CHRISTIAN A HANNON/  
Examiner.Art Unit 2618